

Terahertz induced optical second harmonic generation from dielectric interfaces: mechanism and application

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Optical second harmonic (SH) generation from interfaces of different materials is widely used for surface studies. The surface breaks the symmetry allowing SH generation even in isotropic media. The quality of the surface as well as presence of an additional layers on the surface significantly influence on SH generation. Also, it was shown that application of constant external electric field changes the magnitude of the generated SH signal [1]. In Ref. [2] it was proposed to use a weak THz electric field to modulate SH generation from surface of nontransparent optical material (silicon) as a method to measure THz field waveform. Here we propose to use THz induced SH generated by femtosecond laser radiation to detect optically hidden layers (glue) placed not only on the surface but also into a bulk of transparent materials (quartz). We showed that existence of terahertz radiation influences on SH generation only from the interfaces (glue-quartz, air-quartz) and not from the bulk of the quartz. To explain this effect a model based on interaction of electromagnetic radiation with an electron in coulomb potential biased by embedded surface electric field was proposed and analyzed.

A Ti:Sapphire laser system (1 mJ, 1 kHz, 70 fs) was used in our experiment. The optical beam was divided into two parts (see Fig. 1). The first pulse generated THz radiation in a LiNbO₃ crystal by the tilted-front technique [3]. The THz pulse (the waveform is shown in Fig. 2(a)) was focused on the sample collinear with a probe (weak) femtosecond optical pulse. The sample was fabricated by cementing of two 0.9 mm fused quartz plates by glue with thickness of about several μm . The generated optical SH was detected by PMT in reflection and transmittance setups. In the first setup the sample was placed at 45° to incident probe pulse and PMT detected reflected optical SH. In the second setup the probe optical pulse propagated normally to the incident surface of the sample and PMT detected transmitted optical SH.

Figure 2(b) shows the SH signal as a function of delay time between optical and THz pulses in the transmittance setup (the similar signal but two orders less magnitude was measured in the reflection setup). Due to different velocities of THz and optical pulses, their interaction occurs at different points inside the sample. The measured SH signal at $t = 0$ corresponds to the signal from the entrance surface of the sample, at $t = 1.4$ ps – from the interface glue-quartz, and at $t = 2.7$ ps – from the output boundary of the sample. The dependence obtained in Fig. 2 (b) demonstrates the possibility of determining the presence of internal boundaries in the material that are not visible in the

optical range. With the known values of the refractive indexes for optical and THz radiation, one can find a depth of internal inhomogeneity.

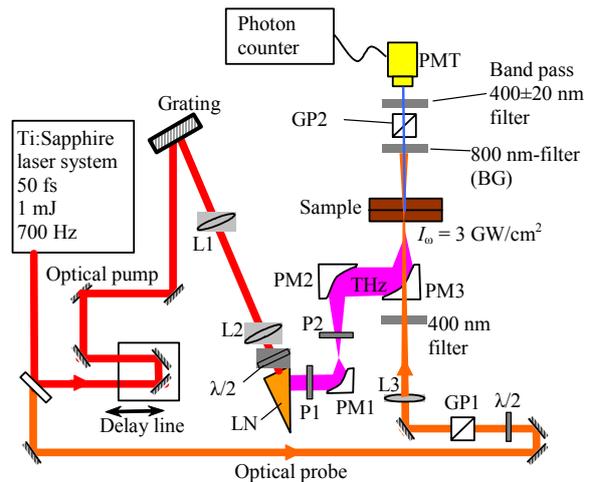


Fig. 1. (a) Experimental setup. LN – LiNbO₃ crystal; PM1, PM2 and PM3 – parabolic mirrors; GP1, GP2 – Glan prisms; PMT – photo multiplier tube; P1, P2 – THz polarizers.

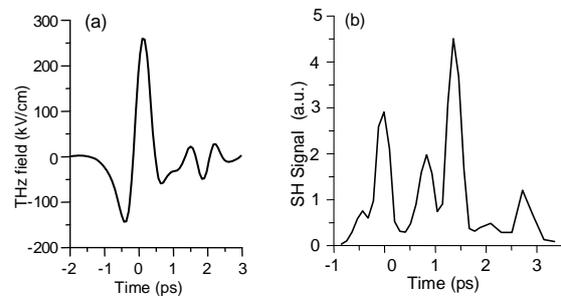


Fig. 2. (a) THz waveform. (b) THz induced optical SH generation from cemented quartz plates.

The fundamental feature of the dependence in Fig. 2(b) is absence (or negligible small value) of SH signal from the bulk. Indeed, the SH in the bulk of isotropic material can be generated by the fundamental harmonic via cubic nonlinearity in the presents of external constant (or low-frequency) field. Thus, the optical and THz pulses should intersect in space. Due to material dispersion the optical and THz pulses interact in the bulk on a walk-off distance $L_w = c\tau / (n_{THz} - n_{opt})$, where τ – THz pulse duration, n_{THz} and n_{opt} – terahertz and optical refraction coefficients, respectively. Taking $\tau = 500$ fs we have for fused quartz $L_w = 300 \mu\text{m}$. Changing the time delay results to moving the position of interaction region inside the sample. If the thickness of the sample (1.8

mm) is more than the walk-off length (as in our experiment) the dependence of SH signal on time delay should have step-like profile with rising and falling times $\tau \approx 0.5$ ps (with possible modulation due to short ~ 10 μm coherent length between first and second optical harmonics). Such signal was not measured in the experiment. At the same time, the signal tracing the form of THz intensity was well observed that indicates the presents of a source of the second harmonic only near the interfaces.

To qualitatively explain the above-discussed experimental result we considered a nonlinear response of hydrogen-like atom in the field of optical and THz radiation. The presence of the interface was modeled by applying additional constant field with corresponding orientation. The simulation was based on 2D and 3D numerical solution of Schrödinger equation. It was shown that near the surface the SH response has a resonance defined by the value of the constant field. Switching-off of the constant field (that corresponds to moving atom into the bulk) leads to a decrease in the second harmonic by several orders of magnitude in agreement with experimental data. This single-particle theory gives a good qualitative explanation of experimental results. For more accuracy (and better

quantitative agreement with experimental data) one should take into account the number of atoms in the bulk and near the surface as well as the dynamics of their radiation.

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